

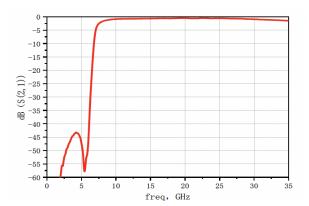
Electrical Specifications (TA=+25°C)

Parameter	Min.	Тур.	Max.	Unit
Cut-off Freq. (f₀)	-	9	-	GHz
Pass band	9	-	30	GHz
Insertion Loss @ f₀	-	-	1.2	dB
Return Loss	12	-	=	dB
Out of band	≥20@6.5GHz			dB
Attenuation	≥40@6.1GHz			dB

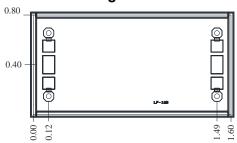
Max. Input Power: 30dBm

Operating Temperature: $-55^{\circ}\text{C} \sim +125^{\circ}\text{C}$ Storage Temperature: $-65^{\circ}\text{C} \sim +150^{\circ}\text{C}$

Typical Wideband Insertion Loss at T_A=25



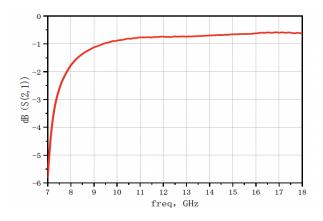
Outline Drawing



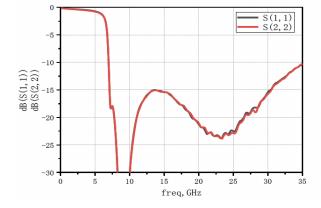
Notes:

- 1. Dimensions are in millimeters. Tolerance: ±0.05 mm
- 2. Die thickness is 0.1 mm
- 3. Typical bond pad size is 0.1 x 0.1 mm

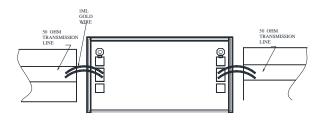
Typical Insertion Loss at T_A=25



Typical Return Loss at T_A=25



Recommended Assembly Diagram



Notes:

- 1. Die is back-metallized and can be mounted with AuSn eutectic preform or with electrically conductive epoxy.
- 2. We recommend using Φ 25um Au wire for wire-bonding, with max wire length of 400um.
- 3. Sinter using AuSn (80/20) alloy, ensuring the temperature does not exceed 300 $^{\circ}\text{C}$ for a maximum of 30 seconds.
- 4. Handle die in clean environment. Do not attempt to clean the chip using liquid cleaning systems.
- 5. Die is ESD sensitive. ESD protection is required during usage and storage.